Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/729,655	SHIEH, SHIUH-AN	
Examiner	Art Unit	
Tai T. Nouven	2612	

	SEAR	CHED	
Class	Subclass	Date	Examiner
340	561 666 667 668	8/16/2006	TN
701	45 46 47	8/16/2006	TN
		1610	

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
		-	
SEARCH /	AS ABOVE	8/16/2006	TN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH	8/16/2006	TN